

Vertex optimization with full simulation

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outline

- optimization of material budget
- Impact parameter resolution

For comparisons

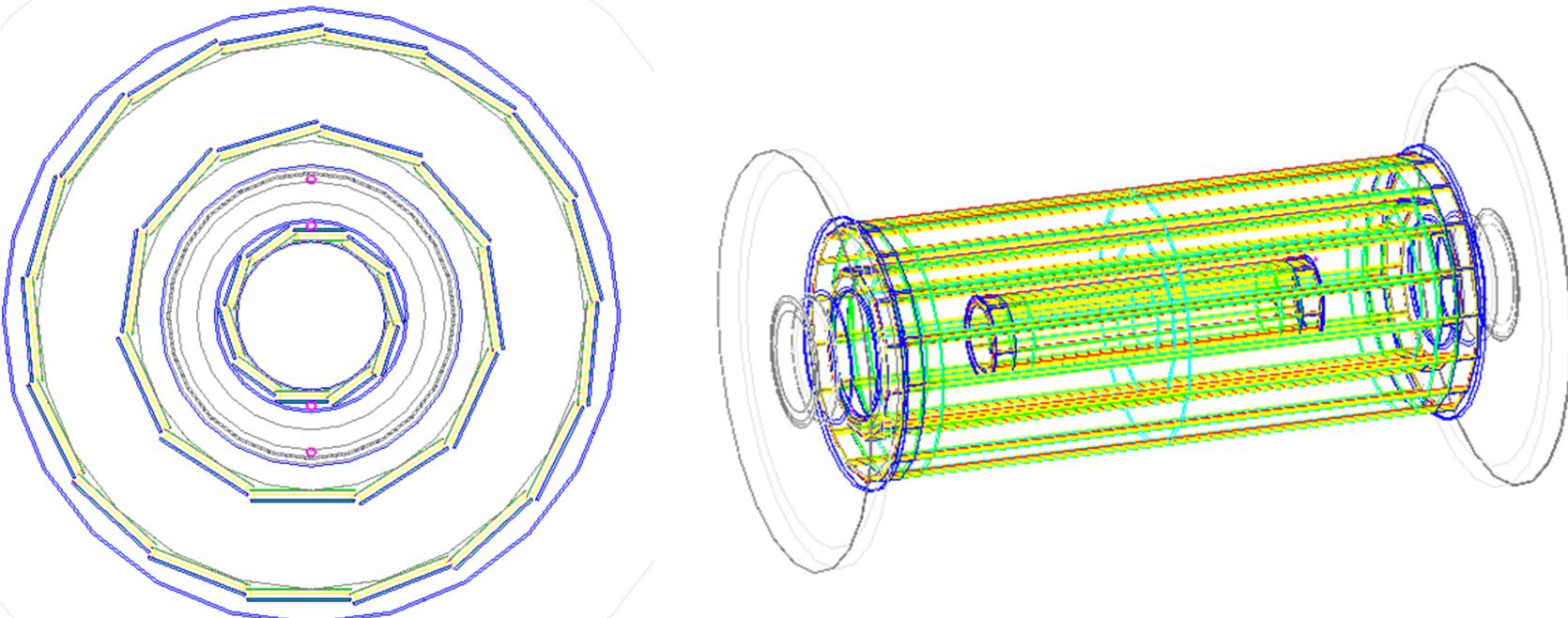
- optimization of distance to IP
- optimization of spatial resolution



VXD structure

■ Material budget (baseline)

- Silicon: 0.000534 X/X₀@50um
- Support: 0.000986 X/X₀@1mm





method

■ Change material budget in Mokka (by C. Fu)

- /Mokka/init/globalModelParameter
 VXDSSupportScale x
- /Mokka/init/globalModelParameter
 VXDSiliconScale x
- Change X from 0.4 to 1.6

$$budget = \frac{thickness \times density}{RadLength}$$



Method

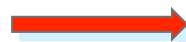
■ Event

- 50000 $z \rightarrow bb$, 50000 $z \rightarrow cc$, 50000 $z \rightarrow ll$ (uds pairs)

generator

Mokka

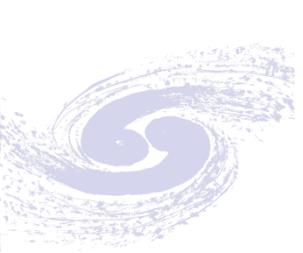
Marlin



$z \rightarrow bb, cc, ll$

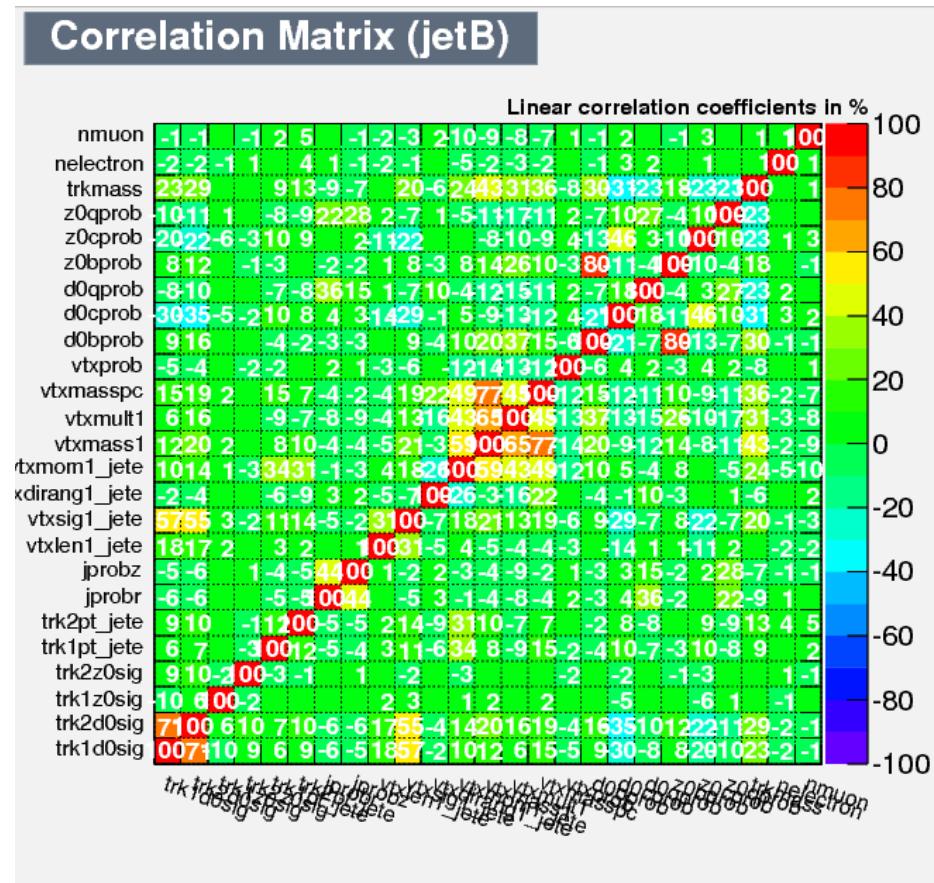
Detector simulation

Digital reconstruction JetClustering train



result

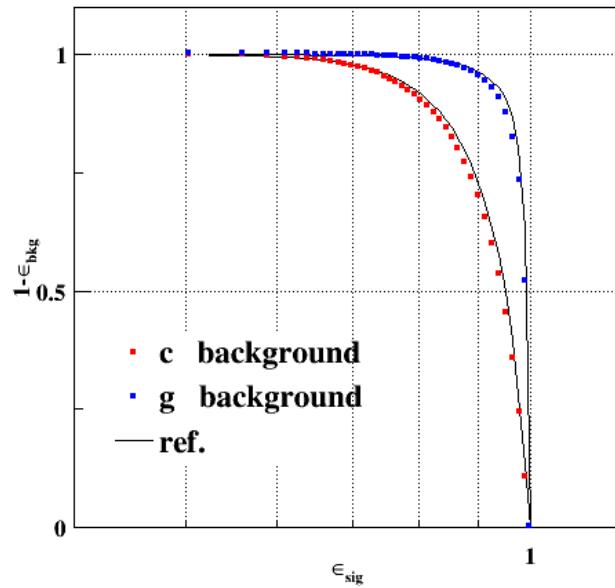
■ CorrelationMatrix



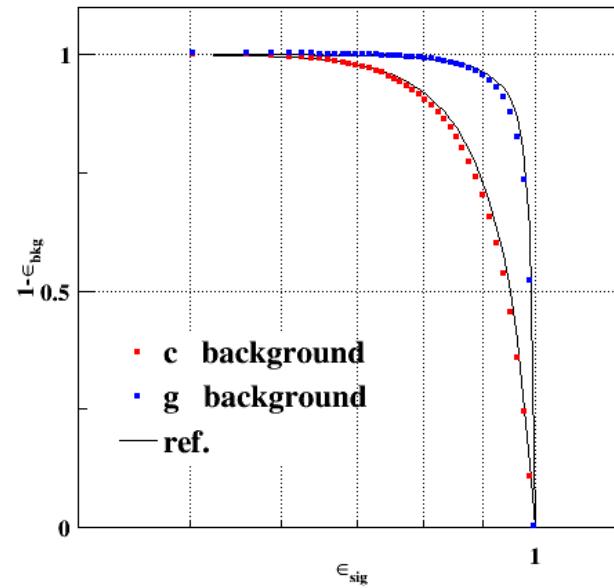


result

■ Training (baseline)



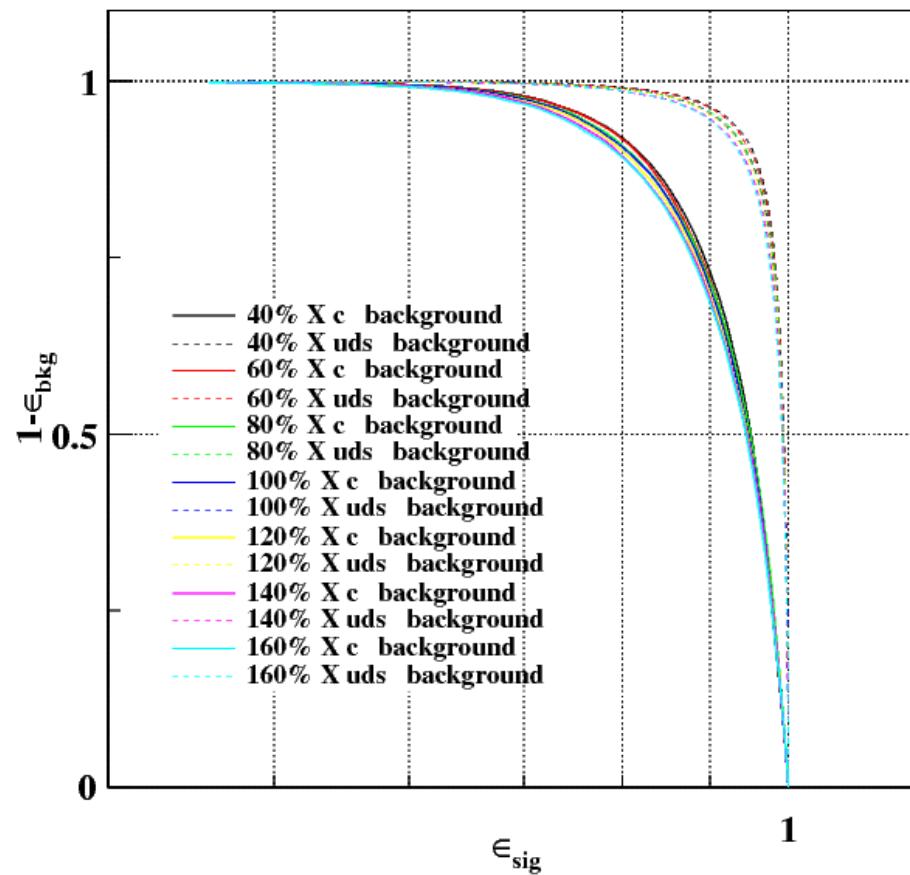
train



test

result

 BROC

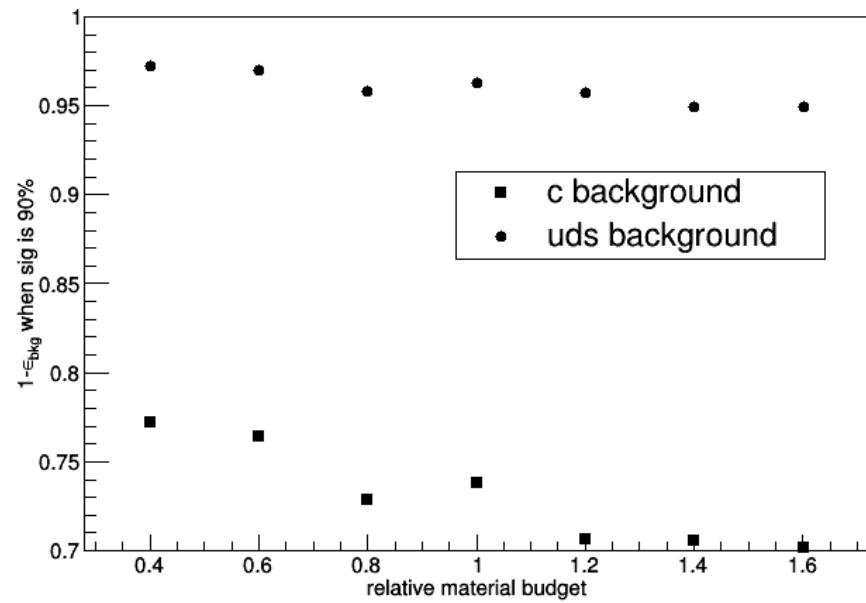
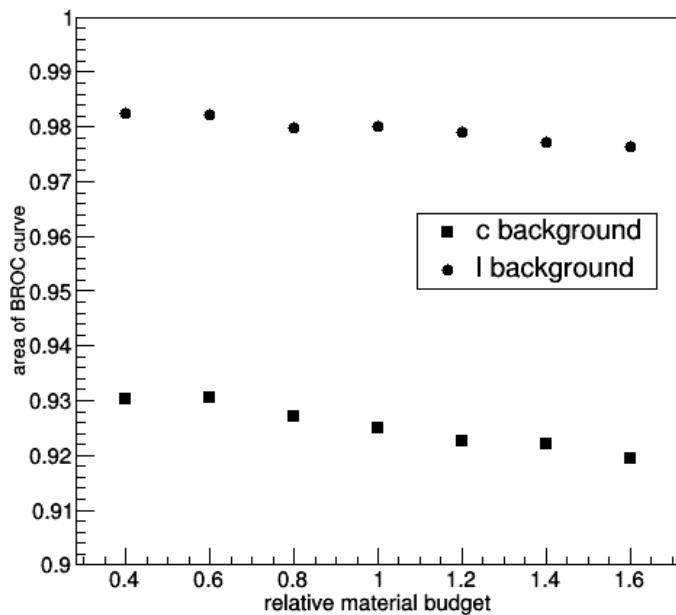




result

■ BROC

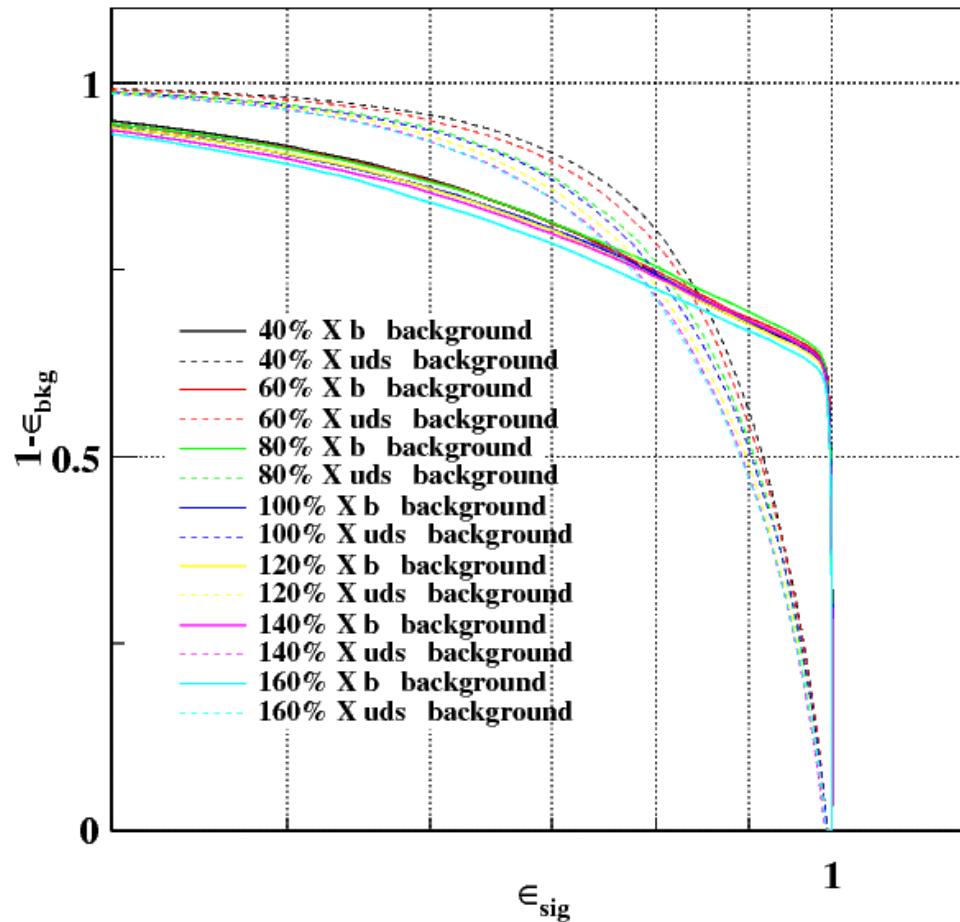
- The reduce of material is inefficient to b-tagging





result

■ CROC

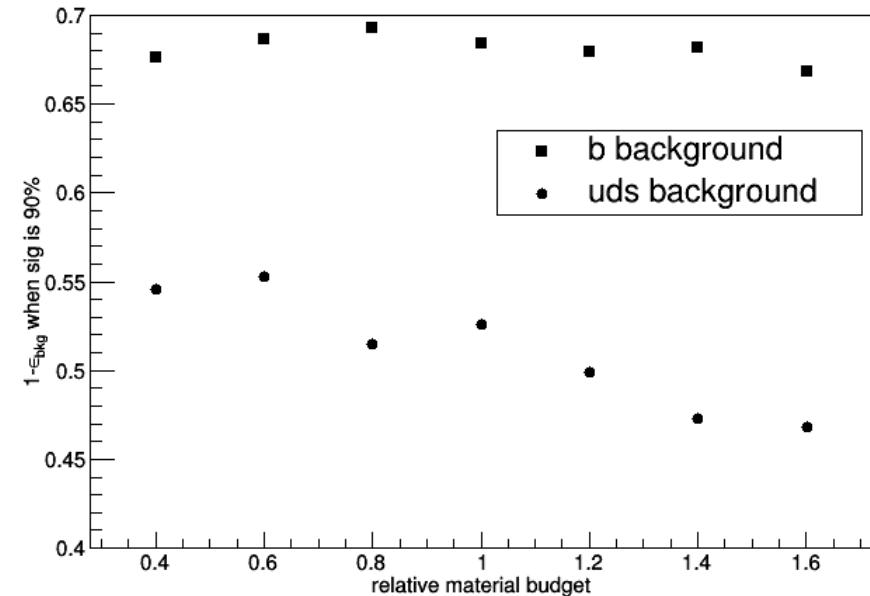
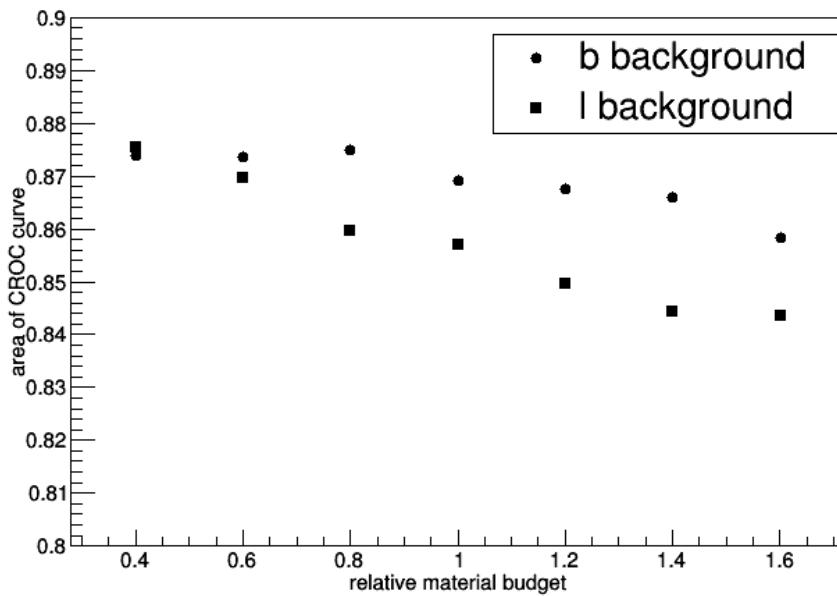




result

■ CROC

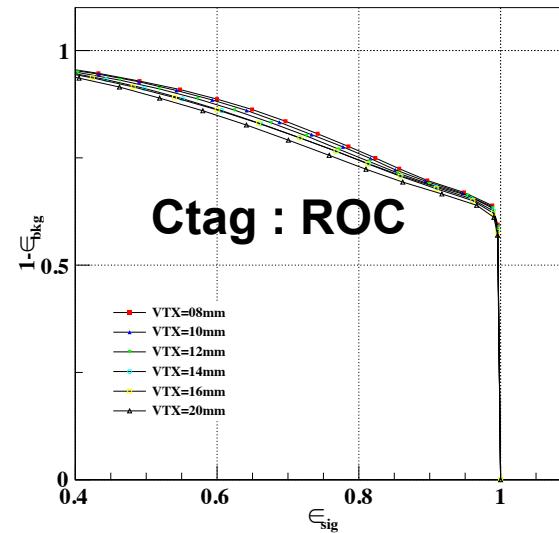
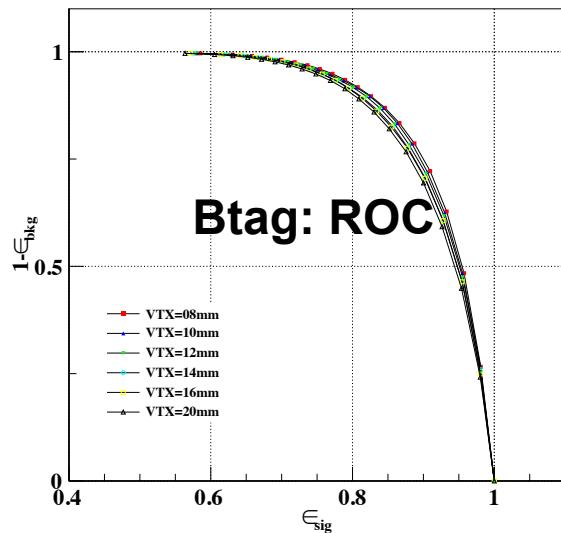
- The reduce of material is efficient to c-tagging (especially uds background)





For comparison

- pushing vertex to IP (by Li.gang)
 - pushing vertex to IP improve Ctag significantly





For comparison

■ Change resolution (by Li.gang)

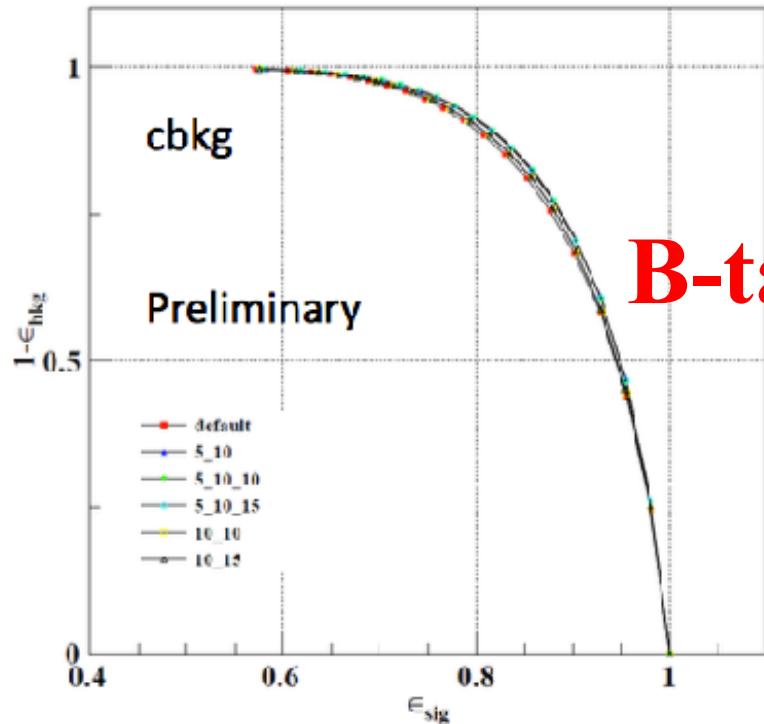
Vertex detector optimization:

- CEPC v1 as default:
- 5_10: VXD 1-6 and FTD_pixel 5 μm , SIT/SET and FTD_strip 10 μm
- 5_10_10: VXD 1 and FTD_pixel 5 μm , VXD 2-6 10 μm , SIT/SET and FTD_strip 10 μm
- 5_10_15: VXD 1 and FTD_pixel 5 μm , VXD 2-6 10 μm , SIT/SET and FTD_strip 15 μm
- 10_10: VXD 1-6 and FTD_pixel 10 μm , SIT/SET and FTD_strip 10 μm
- 10_15: VXD 1-6 and FTD_pixel 10 μm , SIT/SET and FTD_strip 15 μm

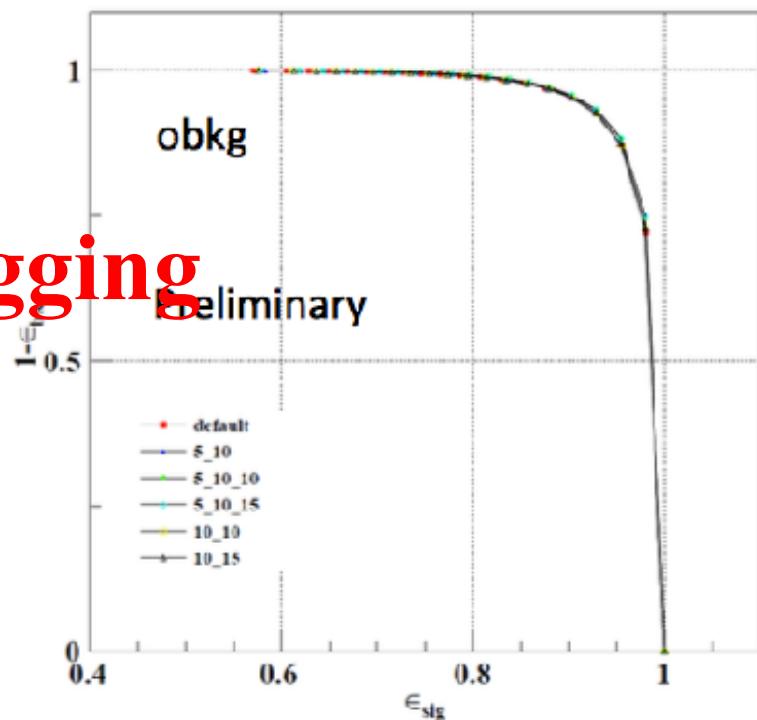


For comparison

■ Change resolution



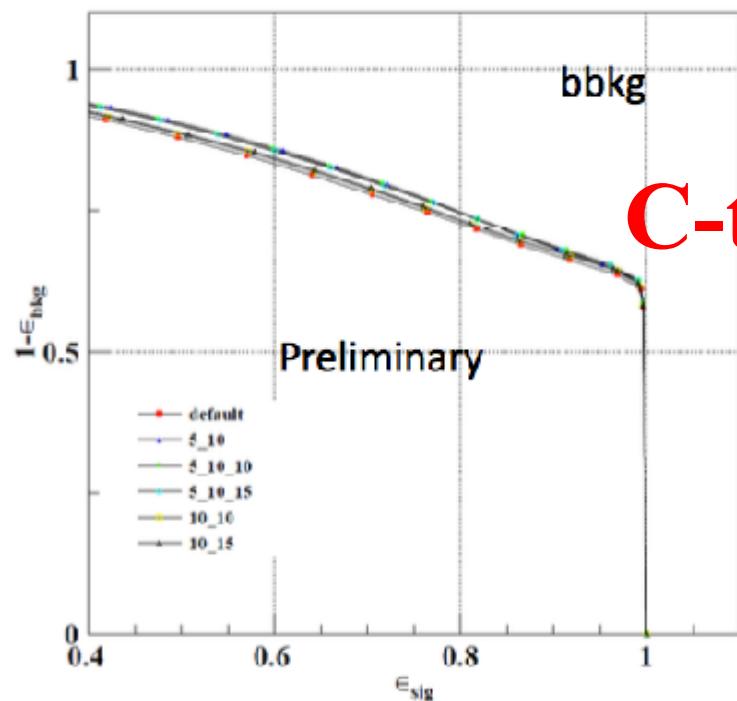
B-tagging



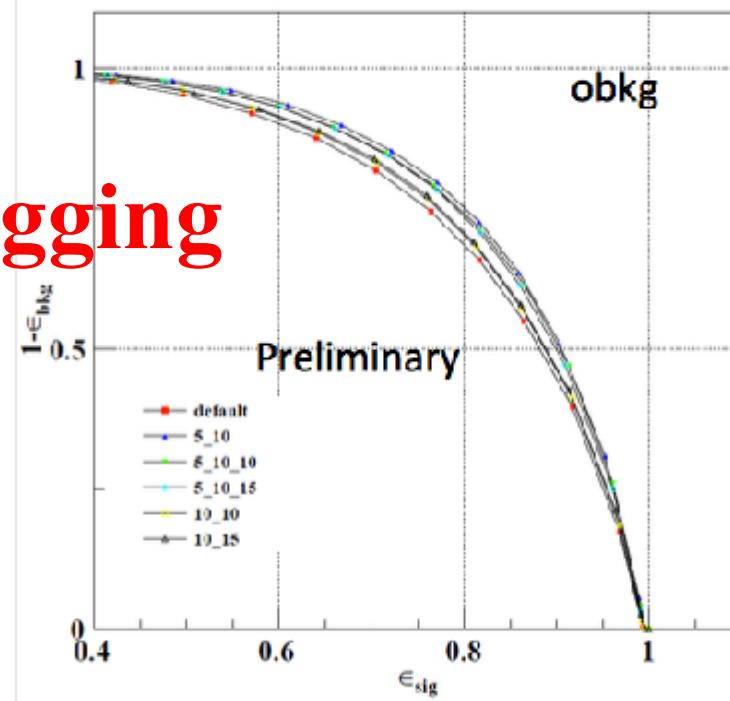


For comparison

■ Change resolution



C-tagging





conclusion

- The optimization of vertex improves c -tagging significantly, while has little influence on b-tagging



transverse impact parameter resolution

■ Definition

- The resolution of **impact parameter** in R- ϕ
 - The closest distance from IP to track

■ Theoretical formula (pre-CDR)

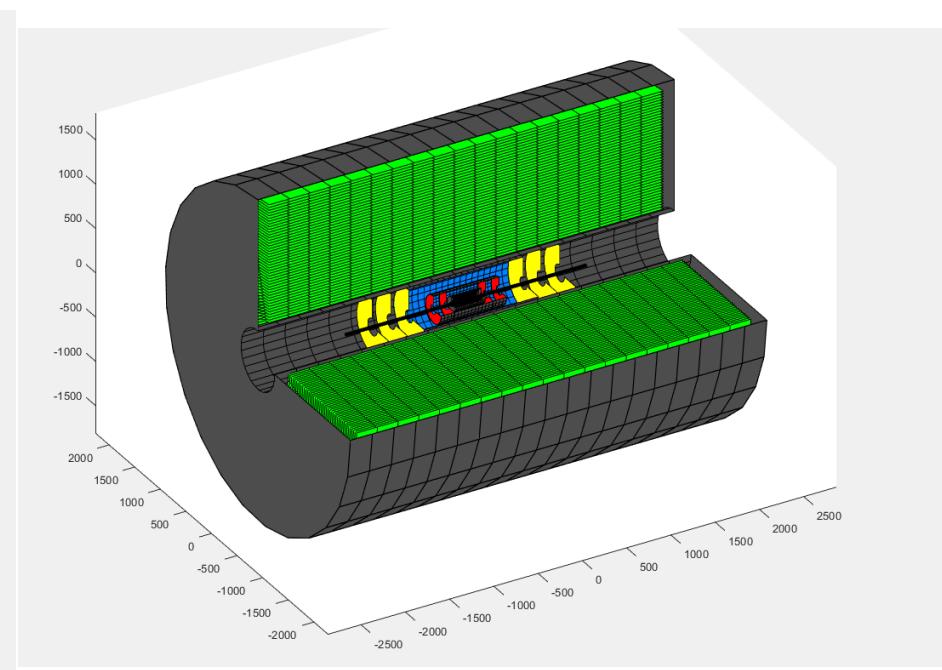
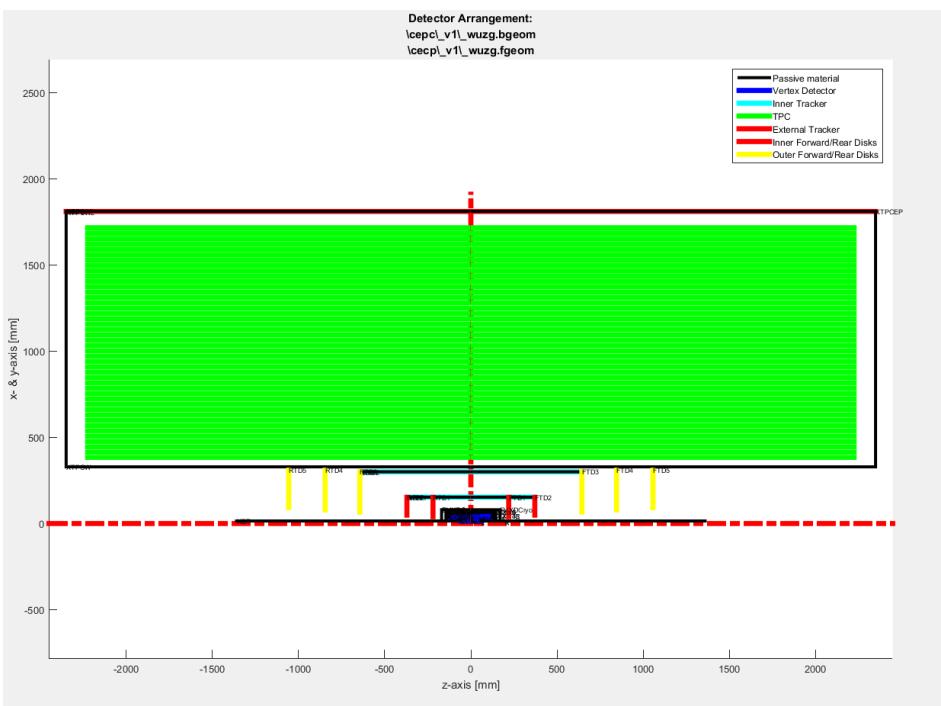
$$\sigma(r\phi) = a \oplus \frac{b}{p(\text{GeV}) \sin^{3/2} \theta} \mu\text{m} \quad \text{when } a=5, b=10$$



Fast simulation

■ Based on MatLab (by Liu.Beijiang)

- Include VXD FTD SIT SET TPC support cooling
- Change the detector structure to CEPC_V1





Full simulation

■ Based on Mokka and Marlin

- Method: TrackImpl.h--->getD0()--->impact parameter

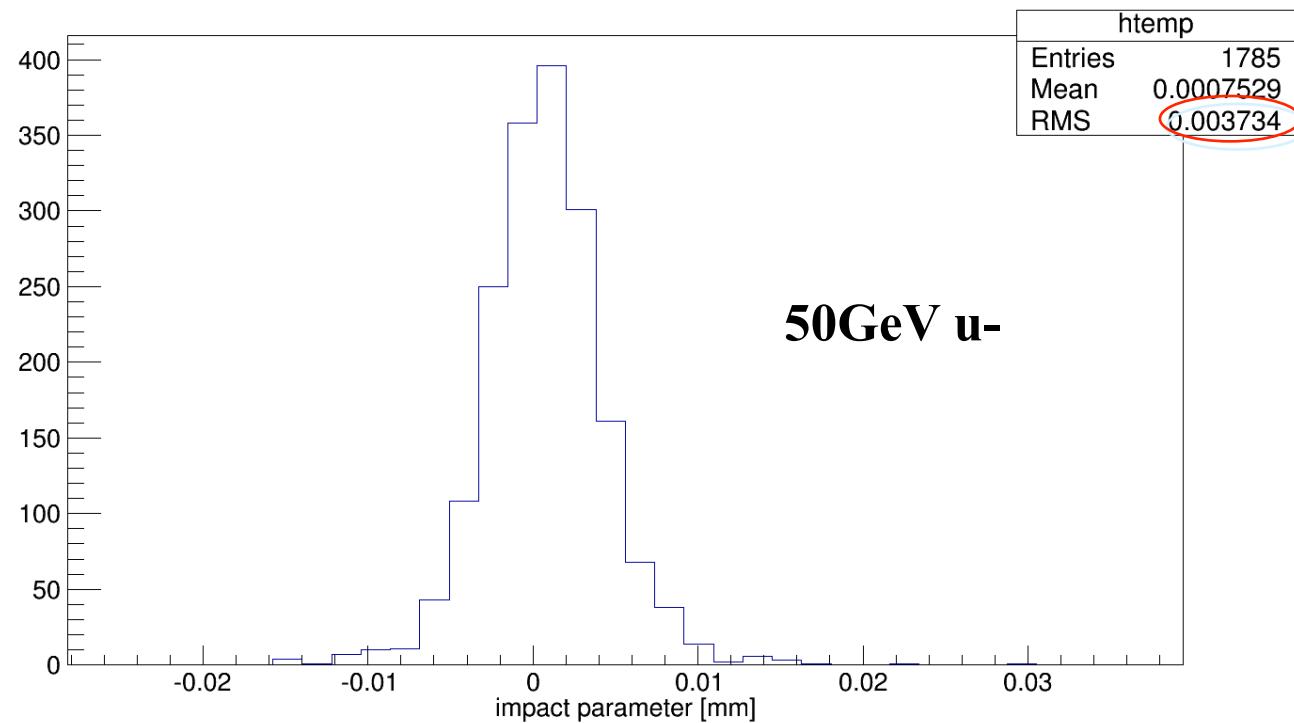
Collection name	algorithm
SiTracks	SiliconTracking_MarlinTrk(VXD、SIT、FTD)
ForwardTracks	ForwardTracking(FTD)
SubsetTracks	Combine SiTracks and ForwardTracks
MarlinTrkTracks	Combine SubsetTracks and TPC



Full simulation

■ Event

- 2000 u- : momentum from 1GeV to 100GeV
- Cut: impact parameter from -0.1mm to 0.1mm





result

■ Simulation based on u-, $\theta = 90^\circ$, Vertical incidence

